





DAC5311, DAC6311, DAC7311 SBAS442D – AUGUST 2008 – REVISED AUGUST 2023

DACx311 2-V to 5.5-V, 80-µA, 8-Bit, 10-Bit, and 12-Bit, Low-Power, Single-Channel, Digital-to-Analog Converters in SC70 Package

1 Features

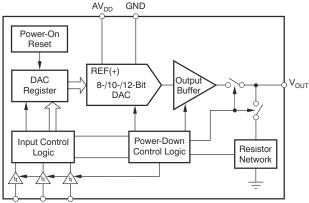
Texas

INSTRUMENTS

- Relative accuracy:
 - 0.25 LSB INL (DAC5311: 8-bit)
 - 0.5 LSB INL (DAC6311: 10-bit)
 - 1 LSB INL (DAC7311: 12-bit)
- microPower operation: 80 µA at 2.0 V
- Power-down: 0.5 μA at 5 V, 0.1 μA at 2.0 V
- Wide power supply: 2.0 V to 5.5 V
- · Power-on reset to zero scale
- Straight binary data format
- Low power serial interface with Schmitt-triggered inputs: up to 50 MHz
- On-chip output buffer amplifier, rail-to-rail operation
- SYNC interrupt facility
- Extended temperature range –40°C to +125°C
- Pin-compatible family in a tiny, 6-pin SC70 package

2 Applications

- Portable, battery-powered instruments
- 4-mA to 20-mA loop-powered applications
- Process control and industrial automation
- Programmable voltage and current sources



SYNC SCLK DIN

Simplified Schematic

3 Description

The 8-bit DAC5311, 10-bit DAC6311, and 12-bit DAC7311 (DACx311) are low-power, single-channel, voltage output digital-to-analog converters (DACs). The low power consumption in normal operation (0.55 mW at 5 V, reducing to 2.5 μ W in power-down mode) makes the DACx311 an excellent choice for portable, battery-operated applications.

These devices are monotonic by design, provide excellent linearity, and minimize undesired codeto-code transient voltages while offering an easy upgrade path within a pin-compatible family. All devices use a versatile, three-wire serial interface that operates at clock rates of up to 50 MHz, and is compatible with standard SPI, QSPI, Microwire, and digital signal processor (DSP) interfaces.

All devices use an external power supply as a reference voltage to set the output range. The devices incorporate a power-on reset (POR) circuit that powers up the DAC output at 0 V and remains at 0 V until a valid write to the device occurs. The DACx311 contain a power-down feature, accessed over the serial interface, that reduces current consumption of the device to 0.1 μ A at 2.0 V in power-down mode.

These devices are pin-compatible with the DAC8311 and DAC8411, offering an easy upgrade path from 8-bit, 10-bit, and 12-bit resolution to 14-bit and 16-bit. All devices are available in a small, 6-pin, SC70 (SOT) package. This package offers a flexible, pin- and function-compatible, drop-in DAC within the family over an extended temperature range of -40° C to $+125^{\circ}$ C.

Device Information⁽¹⁾

PART NUMBER ⁽²⁾	RESOLUTION	PACKAGE SIZE ⁽³⁾
DAC7311	12-bit	
DAC6311		DCK (SC70, 6) 2 mm × 1.5 mm
DAC5311	8-bit	

(1) For all available packages, see the package option addendum at the end of the data sheet.

- (2) See the *Device Comparison Tables*.
- (3) The package size (length × width) is a nominal value and includes pins, where applicable.

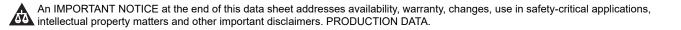




Table of Contents

1 Features	1
2 Applications	
3 Description	
4 Revision History	
5 Device Comparison	
6 Pin Configuration and Functions	
7 Specifications	
7.1 Absolute Maximum Ratings	
7.2 ESD Ratings	
7.3 Recommended Operating Conditions	4
7.4 Thermal Information	4
7.5 Electrical Characteristics	5
7.6 Timing Requirements	7
7.7 Timing Diagrams	7
7.8 Typical Characteristics: AV _{DD} = 5 V	8
7.9 Typical Characteristics: AV _{DD} = 3.6 V	
7.10 Typical Characteristics: AV _{DD} = 2.7 V	
8 Detailed Description	22

8.1 Overview	.22
8.2 Functional Block Diagram	.22
8.3 Feature Description	
8.4 Device Functional Modes	
8.5 Programming	. 25
9 Application and Implementation	
9.1 Application Information	. 26
9.2 Typical Applications	. 27
9.3 Power Supply Recommendations	
9.4 Layout	. 31
10 Device and Documentation Support	32
10.1 Receiving Notification of Documentation Updates.	.32
10.2 Support Resources	. 32
10.3 Trademarks	
10.4 Electrostatic Discharge Caution	.32
10.5 Glossary	
11 Mechanical, Packaging, and Orderable	
Information	. 32

4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

hanges from Revision C (July 2015) to Revision D (August 2023)	Page
Updated the numbering format for tables, figures, and cross-references throughout the document	1
Changed Device Information table to show package size instead of body size and added content to	show
difference among devices	1
Changed power dissipation max value for normal mode at AV _{DD} = 3.6 V to 5.5 V from 0.88 mW to 0	.99 mW in
Electrical Characteristics	5
Changed I _{DD} max value for normal mode at AV _{DD} = 3.6 V to 5.5 V from 160 µA to 180 µA in <i>Electric</i>	al
Characteristics	
hanges from Revision B (May 2013) to Revision C (July 2015)	Page
Added ESD Ratings table, and Feature Description, Device Functional Modes, Application and	
Implementation, Power Supply Recommendations, Layout, Device and Documentation Support, and	b
Mechanical, Packaging, and Orderable Information sections	1
Added Device Comparison section and moved existing tables to this new section	3
Moved Operating Temperature parameter from Electrical Characteristics table to Recommended Op	perating
Conditions table	
Deleted Parameter Definitions section; definitions moved to new Glossary section	32
hanges from Revision A (August 2011) to Revision B (May 2013)	Page
Changed all 1.8 V to 2.0 V throughout data sheet	1
Deleted the 1.8-V Typical Characteristics section	
Changed X-axis for Figure 7-36, Power-Supply Current vs Power-Supply Voltage	<mark>8</mark>
Changed X-axis for Figure 7-37, Power-Down Current vs Power-Supply Voltage	8
hanges from Revision * (August, 2008) to Revision A (August, 2011)	Page
Changed specifications and test conditions for input low voltage parameter	5



5 Device Comparison

Table 5-1. Related Devices					
RELATED DEVICES	16-BIT	14-BIT	12-BIT	10-BIT	8-BIT
Pin and Function Compatible	DAC8411	DAC8311	DAC7311	DAC6311	DAC5311

Table 5-2. Relative Accuracy and Differential Nonlinearity

Differential Normicality					
DEVICE	MAXIMUM RELATIVE ACCURACY (LSB)	MAXIMUM DIFFERENTIAL NONLINEARITY (LSB)			
DAC5311	±0.25	±0.25			
DAC6311	±0.5	±0.5			
DAC7311	±1	±1			

6 Pin Configuration and Functions

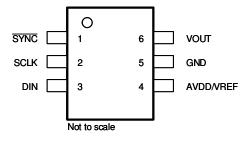


Figure 6-1. DCK Package, 6-Pin SC70 (Top View)

Table 6-1. Pin Functions

PI	1	TYPE	DESCRIPTION
NAME	NO.		DESCRIPTION
AV _{DD} /V _{REF}	4	Input	Power supply input, 2.0 V to 5.5 V.
D _{IN}	3	Input	Serial Data Input. Data are clocked into the 16-bit input shift register on the falling edge of the serial clock input.
GND	5	_	Ground reference point for all circuitry on the part.
SCLK	2	Input	Serial clock input. Data are transferred at rates up to 50 MHz.
SYNC	1	Input	Level-triggered control input (active low). This pin is the frame synchronization signal for the input data. When SYNC goes low, the input shift register is enabled and data are transferred in on the falling edges of the following clocks. The DAC is updated following 16th clock cycle, unless SYNC is taken high before this edge, in which case the rising edge of SYNC acts as an interrupt and the write sequence is ignored by the DACx311. See the SYNC Interrupt section for more details.
V _{OUT}	6	Output	Analog output voltage from DAC. The output amplifier has rail-to-rail operation.



7 Specifications

7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) ⁽¹⁾

			MIN	MAX	UNIT
		AV _{DD} to GND	-0.3	+6	V
	Voltage	Digital input voltage to GND	-0.3	+AV _{DD} + 0.3	V
		V _{OUT} to GND	-0.3	+AV _{DD} + 0.3	V
TJ	Junction temperature			150	°C
T _{stg}	Storage temperature		-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

7.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±1000	V
V _(ESD)	discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±500	v

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM MAX	UNIT
T _A	Operating temperature	-40	125	°C
AV _{DD}	Supply voltage	2	5.5	V

7.4 Thermal Information

		DACx311	
	THERMAL METRIC ⁽¹⁾	DCK (SC70)	UNIT
		6 PINS	
R _{θJA}	Junction-to-ambient thermal resistance	216.4	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	52.1	°C/W
R _{θJB}	Junction-to-board thermal resistance	65.9	°C/W
Ψ _{JT}	Junction-to-top characterization parameter	1.3	°C/W
Ψ _{JB}	Junction-to-board characterization parameter	65.2	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the application report, *Semiconductor and IC Package Thermal Metrics* application note.



7.5 Electrical Characteristics

at AV _{DD} = 2.0 V to 5.5 V, R _L = 2 k Ω to GND, C _L = 200 pF to GND, and T _A = -40°C to +125°C (unless otherwise	
	e noted i
$ \Delta (A A A A A A A A A A $	

F	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
STATIC PERFC	DRMANCE ⁽¹⁾					
DAC5311			8			Bits
DAC6311	Resolution		10			Bits
DAC7311			12			Bits
DAC5311		Measured by the line passing through codes 3 and 252		±0.01	±0.25	LSB
DAC6311	Relative accuracy	Measured by the line passing through codes 12 and 1012		±0.06	±0.5	LSB
DAC7311		Measured by the line passing through codes 30 and 4050		±0.3	±1	LSB
DAC5311				±0.01	±0.25	LSB
DAC6311	Differential nonlinearity			±0.03	±0.5	LSB
DAC7311	nonincentry			±0.2	±1	LSB
Offset error		Measured by the line passing through two codes ⁽²⁾		±0.05	±4	mV
Offset error drift	t			3		µV/°C
Zero code error		All zeros loaded to the DAC register		0.2		mV
Full-scale error		All ones loaded to DAC register		0.04	0.2	% of FSR
Gain error				0.05	±0.15	% of FSR
		AV _{DD} = 5 V		±0.5		ppm of
Gain temperatu	re coefficient	AV _{DD} = 2.0 V		±1.5		FSR/°C
OUTPUT CHAP	RACTERISTICS					
Output voltage	range		0		AV _{DD}	V
Output voltage	settling time ⁽³⁾	R_L = 2 kΩ, C_L = 200 pF, AV_{DD} = 5 V, 1/4 scale to 3/4 scale		6	10	μs
	0	R _L = 2 MΩ, C _L = 470 pF		12		μs
Slew rate				0.7		V/µs
	- 4 - 1- 114	R _L = ∞		470		pF
Capacitive load	stability	$R_L = 2 k\Omega$		1000		pF
Code change gl	litch impulse	1 LSB change around major carry		0.5		nV-s
Digital feedthrou	ugh			0.5		nV-s
D	impulse	$R_{L} = 2 \text{ k}\Omega, C_{L} = 200 \text{ pF}, \text{AV}_{DD} = 5 \text{ V}$		17		mV
Power-on glitch						Ω
DC output impe	dance			0.5		
DC output impe		AV _{DD} = 5 V		0.5 50		mA
-		$AV_{DD} = 5 V$ $AV_{DD} = 3 V$				
DC output impe				50		mA
DC output impe Short circuit cur Power-up time	rent	AV _{DD} = 3 V		50 20		mA mA
DC output impe Short circuit cur Power-up time AC PERFORM	rent	AV _{DD} = 3 V		50 20		mA mA
DC output impe Short circuit cur Power-up time AC PERFORM	rent	AV _{DD} = 3 V Coming out of power-down mode $T_A = 25^{\circ}C, BW = 20 \text{ kHz}, 12\text{-bit level},$		50 20 50		mA mA μs
DC output impe Short circuit cur Power-up time AC PERFORM	rent	AV _{DD} = 3 V Coming out of power-down mode		50 20 50 81		mA mA µs dB



7.5 Electrical Characteristics (continued)

			C to +125°C (unless otherwise noted)
		$n = to(-n) = 2nd + 2 = -/10^{-1}$	$1 10 + 1251 (110) \Delta s c other wise noted)$
a(AV) = 2.0 V (0.0.0 V, 10) = 2	$2 \times 10 \times 10 \times 10 \times 10^{-1} = 200^{-1}$	price OND, and $I_{\Delta} = -\frac{1}{70}$	

PAR	AMETER	TEST	CONDITIONS	MIN	TYP	MAX	UNIT
DAC output noise d	ensity(4)	T _A = 25°C, at zero- f _{OUT} = 1 kHz, AV _{DD}			17		nV/√Hz
DAG output hoise u	enony	$T_A = 25^{\circ}C$, at mid-c $f_{OUT} = 1 \text{ kHz}$, AV_{DD}			110		nV/√Hz
DAC output noise ⁽⁵⁾)	T _A = +25°C, at mid- 0.1 Hz to 10 Hz, AV			3		μV_{PP}
LOGIC INPUTS ⁽³⁾							
Input current						±1	μA
	200	AV _{DD} = 2.7 V to 5.5	5 V			$0.3 \times AV_{DD}$	V
V _{IN} L, Input low volta	age	AV _{DD} = 2.0 V to 2.7	V V			$0.1 \times AV_{DD}$	V
	taga	AV _{DD} = 2.7 V to 5.5	δV	0.7 × AV _{DD}			V
V _{IN} H, Input high vol	lage	AV _{DD} = 2.0 V to 2.7	٧ V	0.9 × AV _{DD}			V
Pin capacitance					1.5	3	pF
POWER REQUIRE	MENTS						
AV _{DD}				2.0		5.5	V
		$V_{IN}H = AV_{DD}$ and	AV _{DD} = 3.6 V to 5.5 V		110	180	μA
	Normal mode	V _{IN} L = GND, at	AV _{DD} = 2.7 V to 3.6 V		95	150	μA
		midscale code ⁽⁶⁾	AV_{DD} = 2.0 V to 2.7 V		80	140	μA
I _{DD}		V _{IN} H = AV _{DD} and	AV_{DD} = 3.6 V to 5.5 V		0.5	3.5	μΑ
	All power-down mode	V _{IN} L = GND, at	AV_{DD} = 2.7 V to 3.6 V		0.4	3	μΑ
		midscale code ⁽⁶⁾	AV_{DD} = 2.0 V to 2.7 V		0.1	2	μΑ
		V _{IN} H = AV _{DD} and	AV _{DD} = 3.6 V to 5.5 V		0.55	0.99	mW
	Normal mode	V _{IN} L = GND, at	AV _{DD} = 2.7 V to 3.6 V		0.25	0.54	mW
Power dissipation –		midscale code ⁽⁶⁾	AV_{DD} = 2.0 V to 2.7 V		0.14	0.38	mW
		$V_{IN}H = AV_{DD}$ and	AV _{DD} = 3.6 V to 5.5 V		2.50	19.2	μW
	All power-down mode	V _{IN} L = GND, at	AV_{DD} = 2.7 V to 3.6 V		1.08	10.8	μW
		midscale code ⁽⁶⁾	AV _{DD} = 2.0 V to 2.7 V		0.72	8.1	μW

(1) Linearity calculated using a reduced code range of 3 to 252 for 8-bit, 12 to 1012 for 10bit, and 30 to 4050 for 12-bit, output unloaded.

(2) Straight line passing through codes 3 and 252 for 8-bit, 12 and 1012 for 10-bit, and 30 and 4050 for 12-bit, output unloaded.

(3) Specified by design and characterization, not production tested.

(4) For more details, see Figure 7-23.

(5) For more details, see Figure 7-24.

(6) For more details, see Figure 7-16 and Figure 7-58.



7.6 Timing Requirements

at -40°C to 125°C, and AV_{DD} = 2 V to 5.5 V (unless otherwise noted)⁽¹⁾

			MIN	NOM MAX	UNIT
f	Serial clock frequency	AV _{DD} = 2.0 V to 3.6 V		20) MHz
f _(SCLK)	Senar clock frequency	AV _{DD} = 3.6 V to 5.5 V		50	
+	SCLK cycle time	AV _{DD} = 2.0 V to 3.6 V	50		ns
t ₁	SCER Cycle une	AV _{DD} = 3.6 V to 5.5 V	20		- 115
+	SCI K high time	AV _{DD} = 2.0 V to 3.6 V	25		
t ₂	SCLK high time	AV _{DD} = 3.6 V to 5.5 V	10	·	ns
+	SCLK low time	AV _{DD} = 2.0 V to 3.6 V	25	·	-
t ₃	SCER IOW UITIE	AV _{DD} = 3.6 V to 5.5 V	10		ns
+	SYNC to SCLK rising edge setup time	AV _{DD} = 2.0 V to 3.6 V	0		
t ₄	Stric to SCLK fising edge setup time	AV _{DD} = 3.6 V to 5.5 V	0		– ns
	Data actus tima	AV _{DD} = 2.0 V to 3.6 V	5		
t ₅	Data setup time	AV _{DD} = 3.6 V to 5.5 V	5		ns
+	Data hold time	AV _{DD} = 2.0 V to 3.6 V	4.5		
t ₆		AV _{DD} = 3.6 V to 5.5 V	4.5		ns
•	SCI K folling adapts SVALC rising adap	AV _{DD} = 2.0 V to 3.6 V	0		
t ₇	SCLK falling edge to SYNC rising edge	AV _{DD} = 3.6 V to 5.5 V	0		ns
•	Minimum <u>EVNC</u> high time	AV _{DD} = 2.0 V to 3.6 V	50		
t ₈	Minimum SYNC high time	AV _{DD} = 3.6 V to 5.5 V	20		ns
+	16th SCLK folling addre to SVNC folling addre	AV _{DD} = 2.0 V to 3.6 V	100		
t ₉	16th SCLK falling edge to SYNC falling edge	AV _{DD} = 3.6 V to 5.5 V	100		– ns
4	SYNC rising edge to 16th SCLK falling edge	AV _{DD} = 2.0 V to 3.6 V	15		
t ₁₀	(for successful SYNC interrupt)	AV _{DD} = 3.6 V to 5.5 V	15		ns

(1) All input signals are specified with $t_R = t_F = 3$ ns (10% to 90% of AV_{DD}) and timed from a voltage level of (V_{IL} + V_{IH}) / 2.

7.7 Timing Diagrams

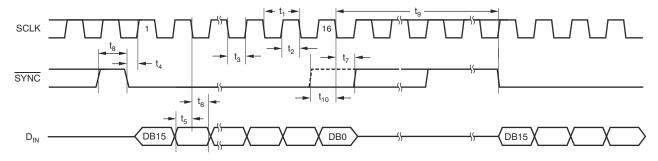
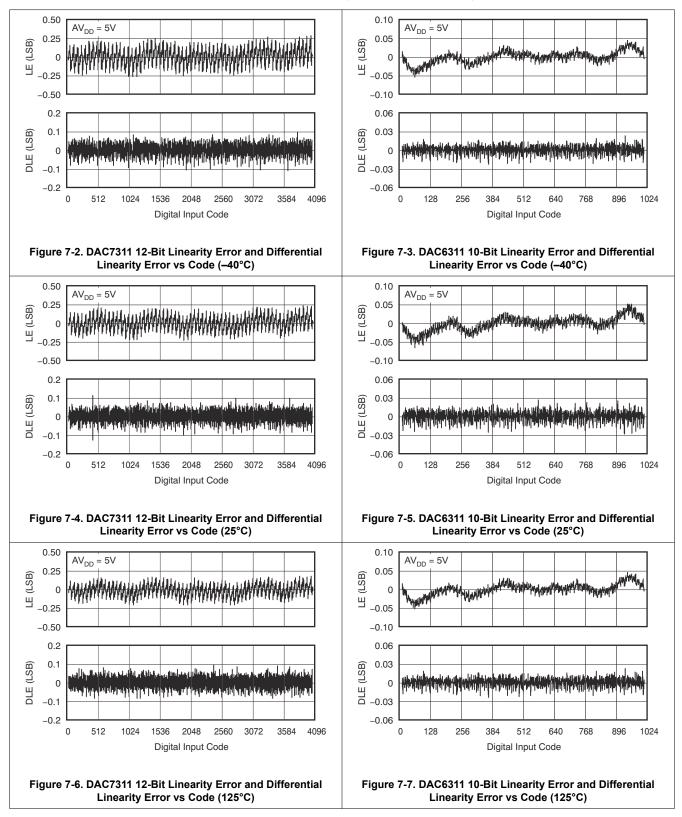


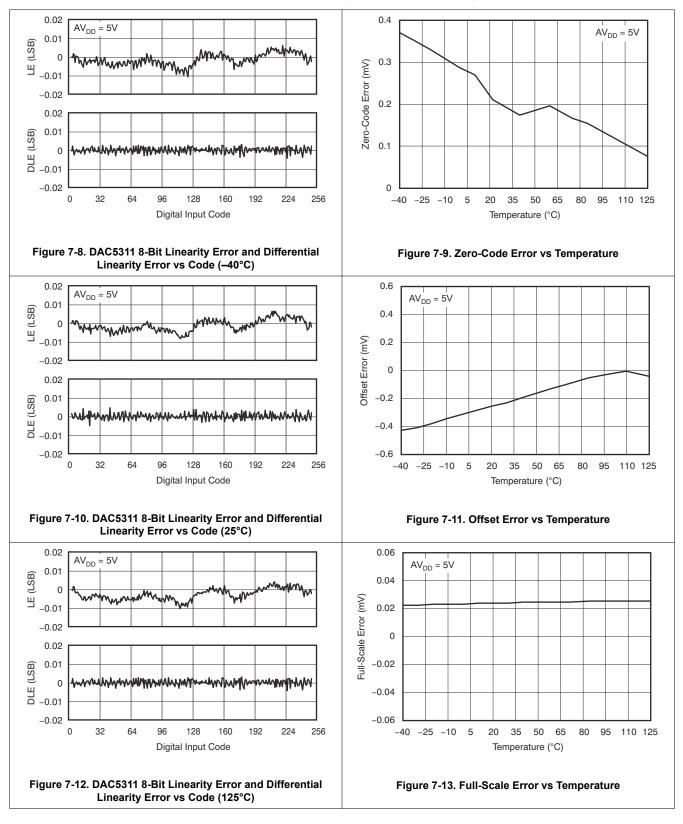
Figure 7-1. Serial Write Operation



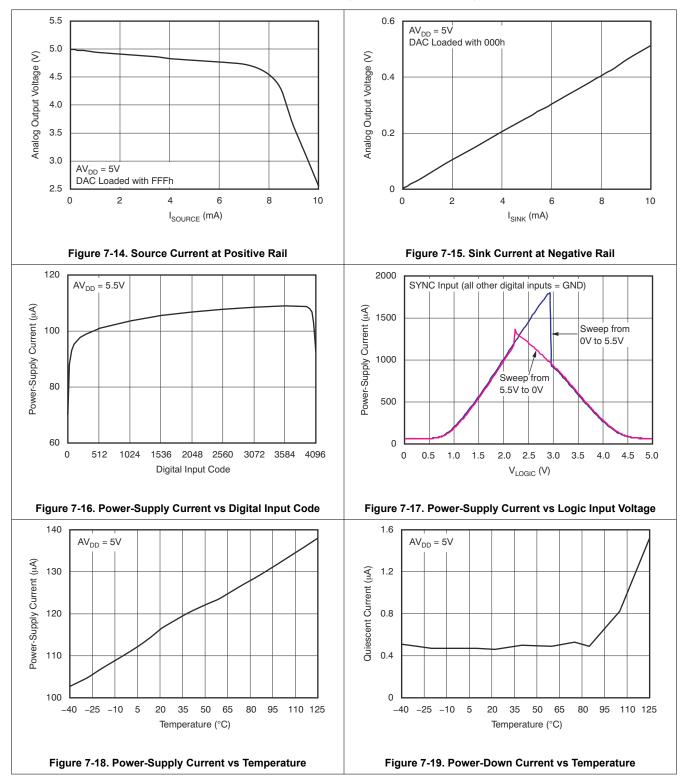
7.8 Typical Characteristics: $AV_{DD} = 5 V$



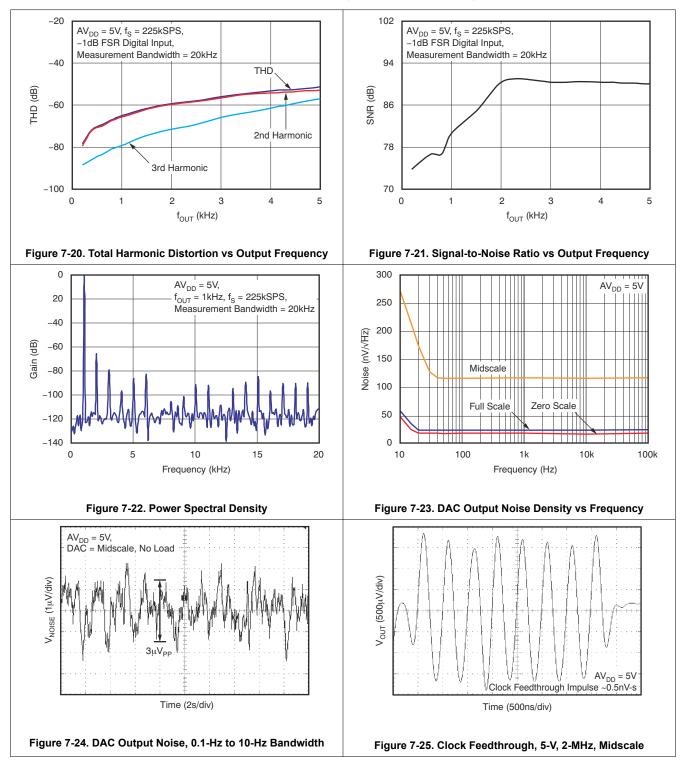




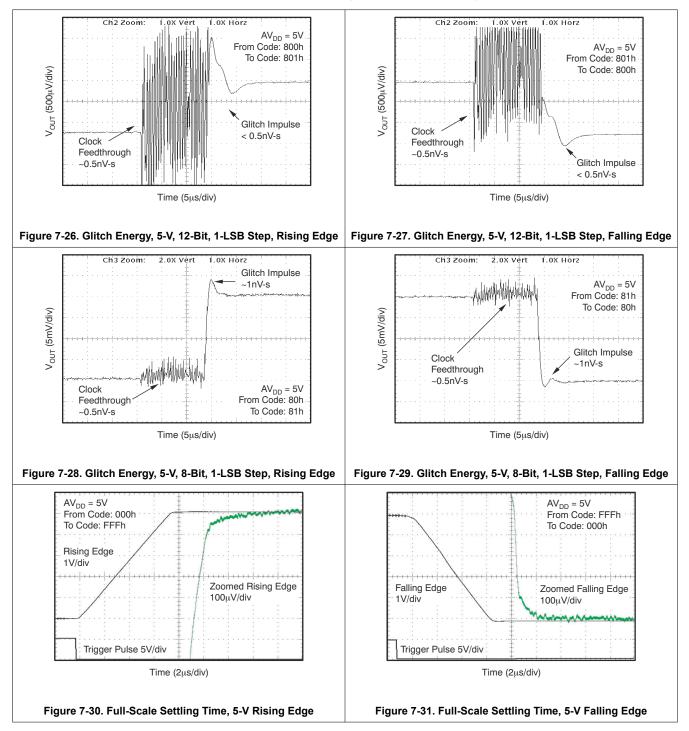






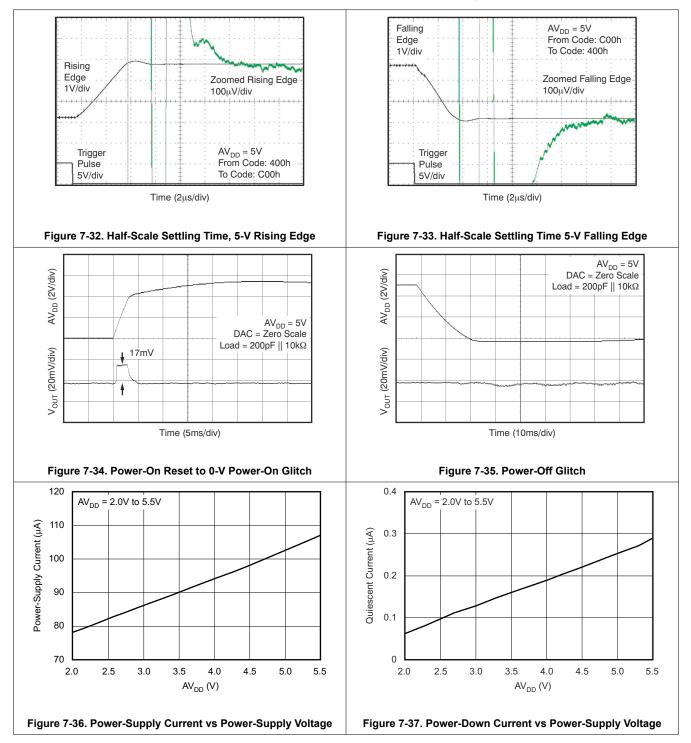






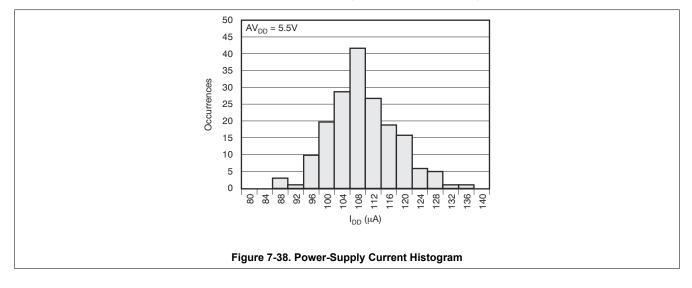


7.8 Typical Characteristics: $AV_{DD} = 5 V$ (continued)



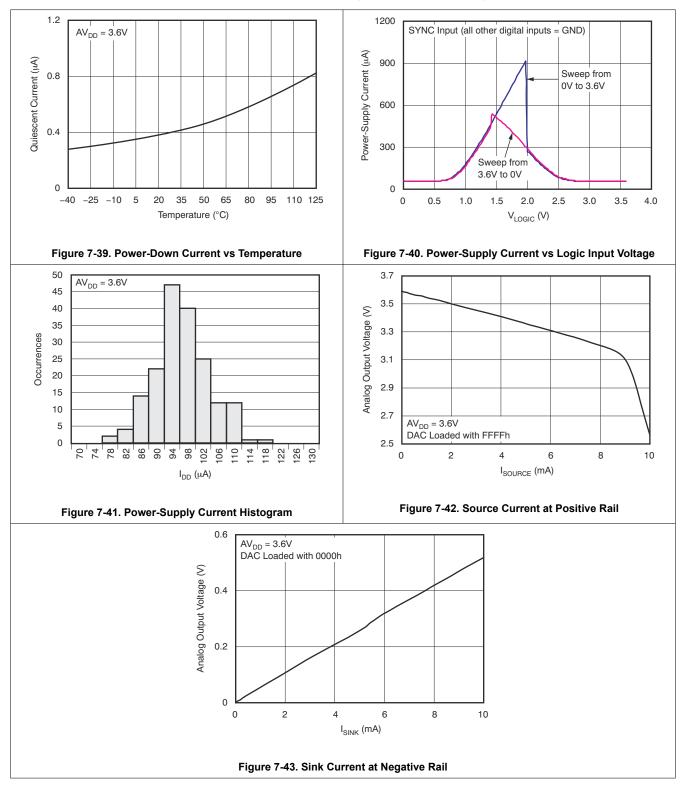


at $T_A = 25^{\circ}$ C, $AV_{DD} = 5$ V, and DAC loaded with midscale code (unless otherwise noted)



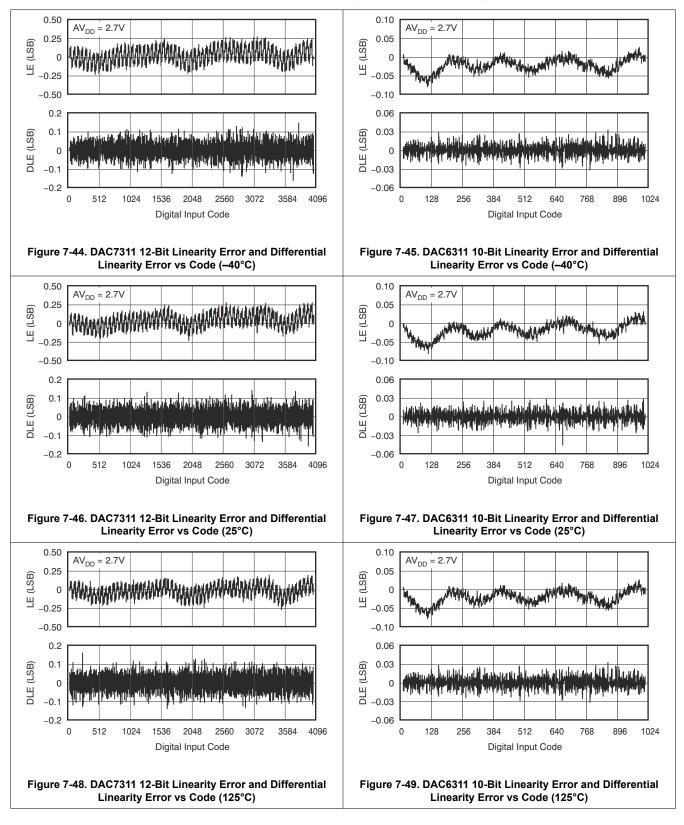


7.9 Typical Characteristics: AV_{DD} = 3.6 V

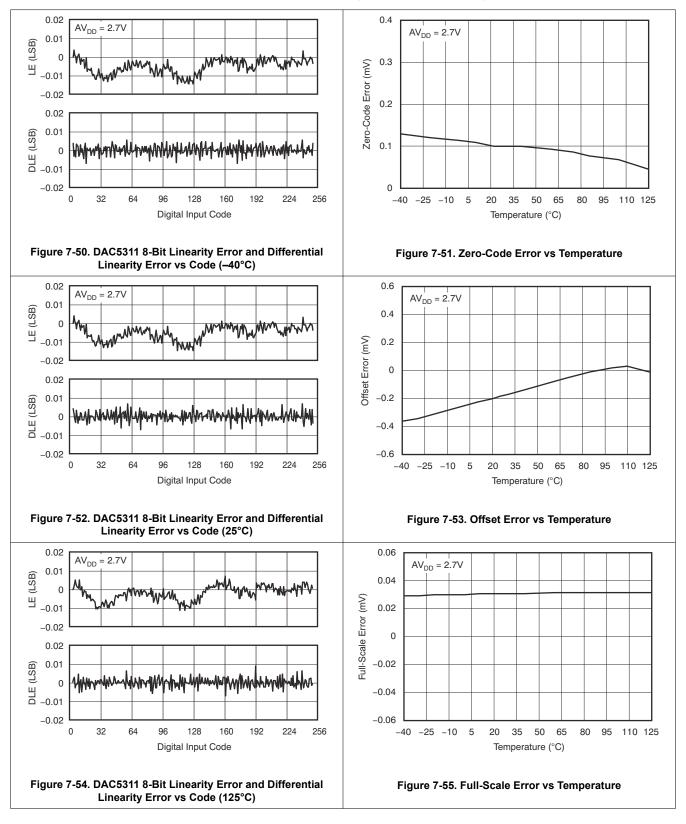




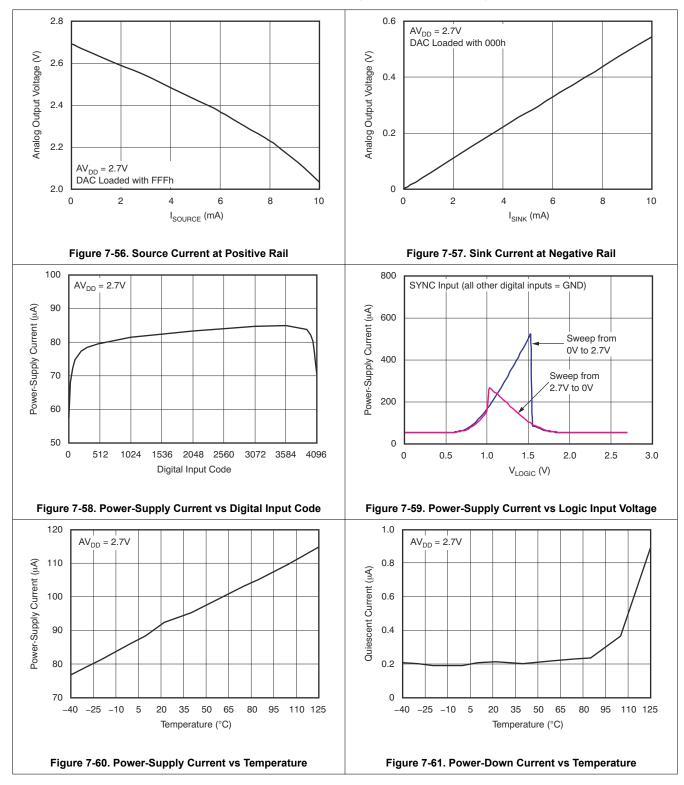
7.10 Typical Characteristics: $AV_{DD} = 2.7 V$



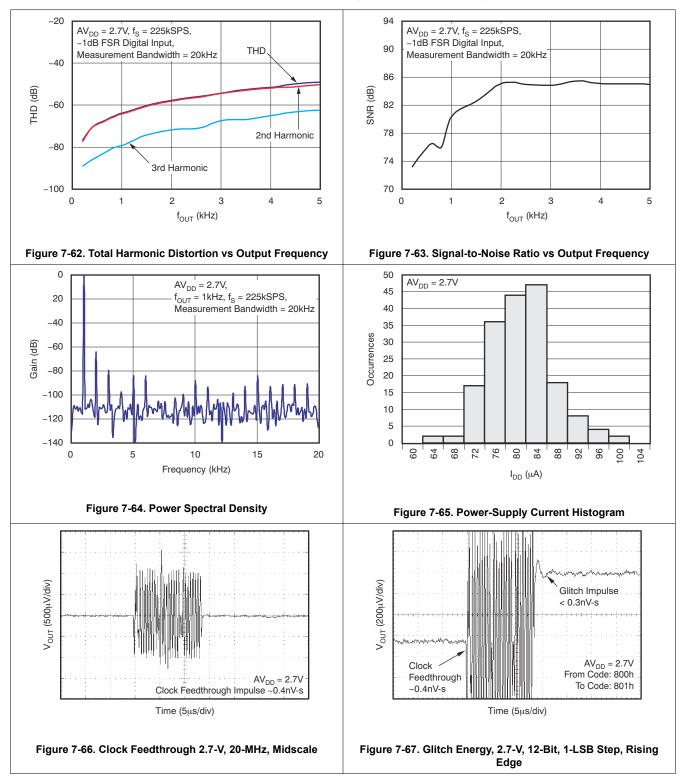




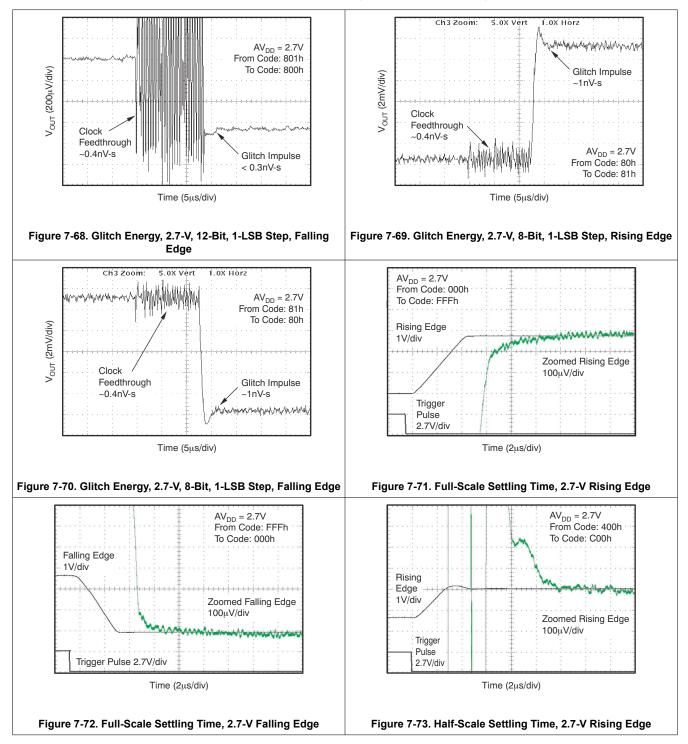




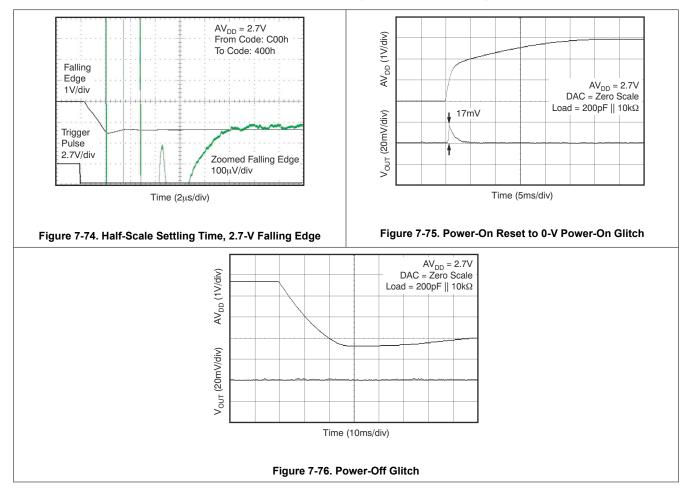












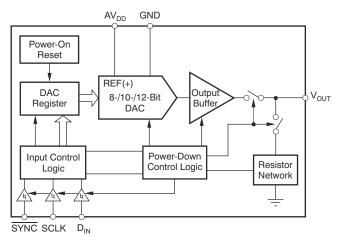


8 Detailed Description

8.1 Overview

The 8-bit DAC5311, 10-bit DAC6311, and 12-bit DAC7311 devices (DACx311) are low-power, single-channel, voltage output DACs. These devices are monotonic by design, provide excellent linearity, and minimize undesired code-to-code transient voltages while offering an easy upgrade path within a pin-compatible family. All devices use a versatile, three-wire serial interface that operates at clock rates of up to 50 MHz and is compatible with standard SPI, QSPI, Microwire, and digital signal processor (DSP) interfaces.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 DAC Section

The DACx311 are fabricated using Texas Instruments' proprietary HPA07 process technology. The architecture consists of a string DAC followed by an output buffer amplifier. Because there is no reference input pin, the power supply (AV_{DD}) acts as the reference. Figure 8-1 shows a block diagram of the DAC architecture.

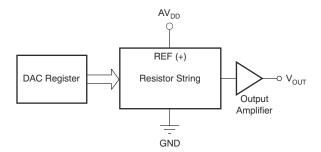


Figure 8-1. DACx311 Architecture

The input coding to the DACx311 is straight binary, so the ideal output voltage is given by:

$$V_{OUT} = AV_{DD} \times \frac{D}{2^n}$$

(1)

where

- n = resolution in bits; either 8 (DAC5311), 10 (DAC6311), or 12 (DAC7311).
- D = decimal equivalent of the binary code that is loaded to the DAC register. D ranges from 0 to 255 for 8-bit DAC5311, 0 to 1023 for the 10-bit DAC6311, and 0 to 4095 for the 12-bit DAC7311.



8.3.2 Resistor String

Figure 8-2 shows the resistor string section, which is a string of resistors, each of value R. The code loaded into the DAC register determines at which node on the string the voltage is tapped off to be fed into the output amplifier by closing one of the switches connecting the string to the amplifier. The resistor string architecture is inherently monotonic.

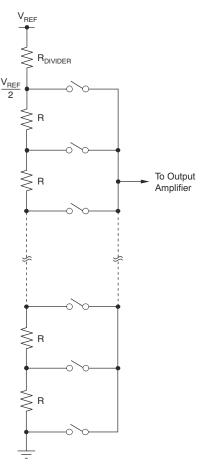


Figure 8-2. Resistor String

8.3.3 Output Amplifier

The output buffer amplifier is capable of generating rail-to-rail voltages on the output, which gives an output range of 0 V to AV_{DD} . The output amplifier is capable of driving a load of 2 k Ω in parallel with 1000 pF to GND. The source and sink capabilities of the output amplifier can be seen in the *Typical Characteristics* section for the given voltage input. The slew rate is 0.7 V/µs with a half-scale settling time of typically 6 µs with the output unloaded.

8.3.4 Power-On Reset

The DACx311 contain a power-on reset circuit that controls the output voltage during power up. On power up, the DAC register is filled with zeros and the output voltage is 0 V. The DAC register remains that way until a valid write sequence is made to the DAC. This design is useful in applications where knowing the state of the DAC output while powering up is important.

The occurring power-on glitch impulse is only a few millivolts (typically, 17 mV; see Figure 7-34).



8.4 Device Functional Modes

8.4.1 Power-Down Modes

The DACx311 contain four separate modes of operation. These modes are programmable by setting two bits (PD1 and PD0) in the control register. Table 8-1 shows how the state of the bits corresponds to the mode of operation of the device.

Table 8-1. Modes of Operation for the DACx311										
PD1	PD0	OPERATING MODE								
NORMAL MODE										
0 0 Normal Operation										
POWER	-DOWN N	NODES								
0	1	Output 1 kΩ to GND								
1	0	Output 100 kΩ to GND								
1	1	High-Z								

When both bits are set to 0, the device works normally with a standard power consumption of typically 80 μ A at 2 V. However, for the three power-down modes, the typical supply current falls to 0.5 μ A at 5 V, 0.4 μ A at 3 V, and 0.1 μ A at 2 V. Not only does the supply current fall, but the output stage is also internally switched from the output of the amplifier to a resistor network of known values. The advantage of this architecture is that the output impedance of the part is known while the part is in power-down mode. There are three different options: the output is connected internally to GND either through a 1-k Ω resistor or a 100-k Ω resistor, or is left open-circuited (High-Z). Figure 8-3 illustrates the output stage.

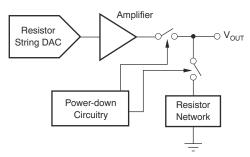


Figure 8-3. Output Stage During Power-Down

All linear circuitry is shut down when the power-down mode is activated. However, the contents of the DAC register are unaffected when in power-down. The time to exit power-down is typically 50 μ s for AV_{DD} = 5 V and AV_{DD} = 3 V.



8.5 Programming

8.5.1 Serial Interface

The DACx311 has a 3-wire serial interface (SYNC, SCLK, and DIN) compatible with SPI, QSPI, and Microwire interface standards, as well as most DSPs. For an example of a typical write sequence, see Figure 7-1.

8.5.1.1 Input Shift Register

The input shift register is 16 bits wide, as shown in Table 8-2. The first two bits (PD0 and PD1) are reserved control bits that set the desired mode of operation (normal mode or any one of three power-down modes) as indicated in Table 8-1.

The remaining data bits are either 12 (DAC7311), 10 (DAC6311), or 8 (DAC5311) data bits, followed by *don't care* bits, as shown in Table 8-2, Table 8-3, and Table 8-4, respectively.

	Table 8-2. DAC5311 8-Bit Data Input Register														
DB15	DB15 DB14 DB6 DB5											DB0			
PD1	PD0	D7	D6	D5	D4	D3	D2	D1	D0	Х	Х	Х	Х	Х	Х

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 8-3. DAC6311 10-Bit Data Input Register

DB15	DB14										DB4	DB3			DB0
PD1	PD0	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	Х	Х	Х	Х

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

Table 8-4. DAC7311 12-Bit Data Input Register

DB15	DB14												DB2	DB1	DB0
PD1	PD0	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	Х	X

LEGEND: R/W = Read/Write; R = Read only; -n = value after reset

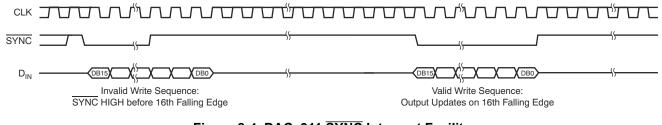
The write sequence begins by bringing the \overline{SYNC} line low. Data from the DIN line are clocked into the 16-bit shift register on each falling edge of SCLK. The serial clock frequency can be as high as 50 MHz, making

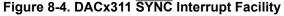
the DACx311 compatible with high-speed DSPs. On the 16th falling edge of the serial clock, the last data bit is clocked in and the programmed function is executed.

At this point, the <u>SYNC</u> line can be kept low or brought high. In either case, <u>SYNC</u> must be brought high for a minimum of 20 ns before the next write sequence so that a falling edge of <u>SYNC</u> can initiate the next write sequence.

8.5.1.2 SYNC Interrupt

In a normal write sequence, the \overline{SYNC} line is kept low for at least 16 falling edges of SCLK and the DAC is updated on the 16th falling edge. However, bringing \overline{SYNC} high before the 16th falling edge acts as an interrupt to the write sequence. The shift register is reset and the write sequence is seen as invalid. Neither an update of the DAC register contents nor a change in the operating mode occurs, as shown in Figure 8-4.







9 Application and Implementation

Note

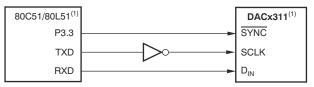
Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

9.1.1 Microprocessor Interfacing

9.1.1.1 DACx311 to 8051 Interface

Figure 9-1 shows a serial interface between the DACx311 and a typical 8051-type microcontroller. The setup for the interface is as follows: TXD of the 8051 drives SCLK of the DACx311, while RXD drives the serial data line of the device. The SYNC signal is derived from a bit programmable pin on the port. In this case, port line P3.3 is used. When data are to be transmitted to the DACx311, P3.3 is taken low. The 8051 transmits data only in 8-bit bytes; thus, only eight falling clock edges occur in the transmit cycle. To load data to the DAC, P3.3 remains low after the first eight bits are transmitted, and a second write cycle is initiated to transmit the second byte of data. P3.3 is taken high following the completion of this cycle. The 8051 outputs the serial data in a format that has the LSB first. The DACx311 requires data with the MSB as the first bit received. Therefore, the 8051 transmit routine must take this requirement into account, and *mirror* the data as needed.

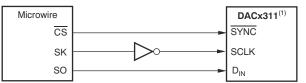


NOTE: (1) Additional pins omitted for clarity.

Figure 9-1. DACx311 to 80C51/80I51 Interfaces

9.1.1.2 DACx311 to Microwire Interface

Figure 9-2 shows an interface between the DACx311 and any Microwire-compatible device. Serial data (SO) are shifted out on the falling edge of the serial clock (SK) and are clocked into the DACx311 on the rising edge of the SK signal.



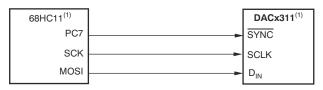
NOTE: (1) Additional pins omitted for clarity.

Figure 9-2. DACx311 to Microwire Interface



9.1.1.3 DACx311 to 68HC11 Interface

Figure 9-3 shows a serial interface between the DACx311 and the 68HC11 microcontroller. SCK of the 68HC11 drives the SCLK of the DACx311, while the MOSI output drives the serial data line of the DAC. The SYNC signal is derived from a port line (PC7), similar to what was done for the 8051.



NOTE: (1) Additional pins omitted for clarity.

Figure 9-3. DACx311 to 68HC11 Interface

Configure the 68HC11 so that the CPOL bit is 0 and the CPHA bit is 1. This configuration causes data appearing on the MOSI output to be valid on the falling edge of SCK. When data are being transmitted to the DAC, the SYNC line is taken low (PC7). Serial data from the 68HC11 are transmitted in 8-bit bytes with only eight falling clock edges occurring in the transmit cycle. Data are transmitted MSB first. To load data to the DACx311, PC7 is held low after the first eight bits are transferred, and a second serial write operation is performed to the DAC; PC7 is taken high at the end of this procedure.

9.2 Typical Applications

9.2.1 Loop Powered Transmitter

The described loop powered transmitter can accurately source currents from 4 mA to 20 mA.

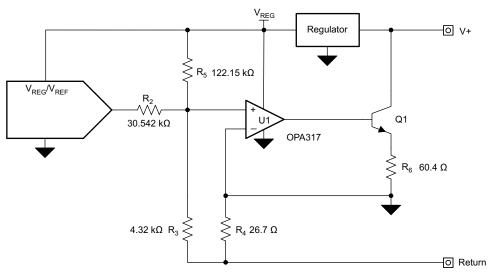


Figure 9-4. Loop Powered Transmitter Schematic

9.2.1.1 Design Requirements

The transmitter has only two external input pins; a supply connection and a ground (or return) connection. The transmitter communicates back to the host, typically a PLC analog input module, by precisely controlling the magnitude of the return current. To conform to the 4-mA to 20-mA communication standards, the complete transmitter must consume less than 4 mA of current.

The complete design of this circuit is outlined in TIPD158, *Low Cost Loop-Powered 4-20mA Transmitter EMC/EMI Tested Reference Design*. The design is expected to be low-cost and deliver immunity to the IEC61000-4 suite of tests with minimum impact on the accuracy of the system. Reference design TIPD158 includes the design goals, simulated results, and measured performance.

Copyright © 2023 Texas Instruments Incorporated



9.2.1.2 Detailed Design Procedure

Amplifier U1 uses negative feedback to make sure that the potentials at the inverting (V–) and noninverting (V+) input terminals are equal. In this configuration, V– is directly tied to the local GND; therefore, the potential at the noninverting input terminal is driven to local ground. Thus, the voltage difference across R_2 is the DAC output voltage (VOUT), and the voltage difference across R_5 is the regulator voltage (VREG). These voltage differences cause currents to flow through R_2 and R_5 , as illustrated in Figure 9-5.

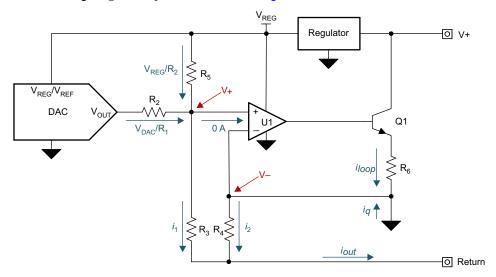


Figure 9-5. Voltage to Current Conversion

The currents from R_2 and R_5 sum into i_1 (defined in Equation 2), and i_1 flows through R_3 .

$$i_1 = \frac{V_{DAC}}{R_2} + \frac{V_{REG}}{R_5}$$
(2)

Amplifier U2 drives the base of Q1, the NPN bipolar junction transistor (BJT), to allow current to flow through R_4 so that the voltage drops across R_3 and R_4 remain equal. This design keeps the inverting and noninverting terminals at the same potential. A small part of the current through R_4 is sourced by the quiescent current of all of the components used in the transmitter design (regulator, amplifier, and DAC). The voltage drops across R_3 and R_4 are equal; therefore, different-sized resistors cause different current flow through each resistor. Use these different-sized resistors to apply gain to the current flow through R_4 by controlling the ratio of resistor R_3 to R_4 , as shown in Equation 3:

$$V_{+} = i_{1} \cdot R_{3}$$

$$V_{-} = i_{2} \cdot R_{4} \implies i_{2} = \frac{i_{1} \cdot R_{3}}{R_{4}}$$

$$V_{+} = V_{-}$$
(3)

The current gain in the circuit helps allow a majority of the output current to come directly from the loop through Q1 instead of from the voltage-to-current converter. This current gain, in addition to the low-power components, keeps the current consumption of the voltage-to-current converter low. Currents i_1 and i_2 sum to form output current i_{out} , as shown in Equation 4:

$$i_{out} = i_1 + i_2 = \frac{V_{DAC}}{R_2} + \frac{V_{REG}}{R_5} + \frac{R_3}{R_4} \cdot \left(\frac{V_{DAC}}{R_2} + \frac{V_{REG}}{R_5}\right) = \left(\frac{V_{DAC}}{R_2} + \frac{V_{REG}}{R_5}\right) \cdot \left(1 + \frac{R_3}{R_4}\right)$$
(4)

The complete transfer function, arranged as a function of input code, is shown in Equation 5. The remaining sections divide this circuit into blocks for simplified discussion.



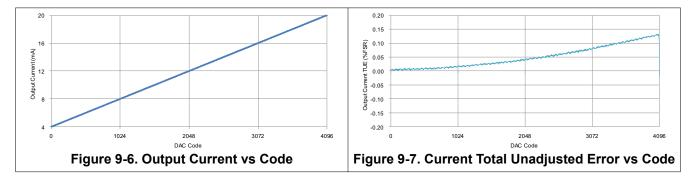
(5)

$$i_{out} \left(Code \right) = \left(\frac{V_{REG} \cdot Code}{2^{Resolution} \cdot R_2} + \frac{V_{REG}}{R_5} \right) \cdot \left(1 + \frac{R_3}{R_4} \right)$$

Resistor R_6 is included to reduce the gain of transistor Q1, and therefore, reduce the closed-loop gain of the voltage-to-current converter for a stable design. Size resistors R_2 , R_3 , R_4 , and R_5 based on the full-scale range of the DAC, regulator voltage, and the desired current output range of the design.

9.2.1.3 Application Curves

Figure 9-6 shows the measured transfer function of the circuit. Figure 9-7 shows the total unadjusted error (TUE) of the circuit, staying below 0.15 %FSR.



9.2.2 Using the REF5050 as a Power Supply for the DACx311

As a result of the extremely low supply current required by the DACx311, an alternative option is to use a REF5050 5-V precision voltage reference to supply the required voltage to the part, as shown in Figure 9-8. This option is especially useful if the power supply is too noisy or if the system supply voltages are at some value other than 5 V. The REF5050 outputs a steady supply voltage for the DACx311. If the REF5050 is used, the current needed to supply DACx311 is typically 110 μ A at 5 V, with no load on the output of the DAC. When the DAC output is loaded, the REF5050 also needs to supply the current to the load. The total current required (with a 5 k Ω load on the DAC output) is:

(6)

The load regulation of the REF5050 is typically 0.002%/mA, which results in an error of 90 μ V for the 1.1 mA current drawn from the device. This value corresponds to a 0.07 LSB error at 12 bits (DAC7311).

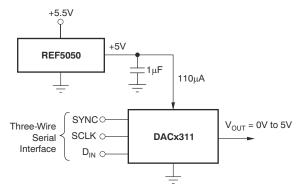


Figure 9-8. REF5050 as Power Supply to DACx311

For other power-supply voltages, alternative references such as the REF3030 (3 V), REF3033 (3.3 V), or REF3220 (2.048 V) are recommended. For a full list of available voltage references from TI, see the TI web site at www.ti.com.

Copyright © 2023 Texas Instruments Incorporated



9.2.3 Bipolar Operation Using the DACx311

The DACx311 has been designed for single-supply operation but a bipolar output range is also possible using the circuit in Figure 9-9. The circuit shown gives an output voltage range of ±5 V. Rail-to-rail operation at the amplifier output is achievable using an OPA211, OPA340, or OPA703 as the output amplifier. For a full list of available operational amplifiers from TI, see the TI web site at www.ti.com

The output voltage for any input code can be calculated as follows:

$$V_{O} = \left[AV_{DD} \times \left(\frac{D}{2^{n}}\right) \times \left(\frac{R_{1} + R_{2}}{R_{1}}\right) - AV_{DD} \times \left(\frac{R_{2}}{R_{1}}\right) \right]$$
(7)

where

- n = resolution in bits; either 8 (DAC5311), 10 (DAC6311), or 12 (DAC7311).
- D = decimal equivalent of the binary code that is loaded to the DAC register. D ranges from 0 to 255 for 8-bit DAC5311, 0 to 1023 for the 10-bit DAC6311 and 0 to 4095 for the 12-bit DAC7311.

With $AV_{DD} = 5 V$, $R_1 = R_2 = 10 k\Omega$:

$$V_{O} = \left(\frac{10 \times D}{2^{n}}\right) - 5V$$
(8)

The resulting output voltage range is ± 5 V. Code 000h corresponds to a -5-V output and FFFh (12-bit level) corresponding to a +5-V output.

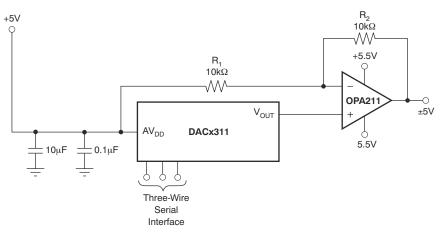


Figure 9-9. Bipolar Operation With the DACx311

9.3 Power Supply Recommendations

The DACx311 is designed to operate with a unipolar analog power supply ranging from 2.0 V to 5.5 V on the AV_{DD} pin. The AV_{DD} pin supplies power to the digital and analog circuits (including the resistor string) inside the DAC. The current consumption of this pin is specified in the *Electrical Characteristics* table. Use a 1 μ F to 10 μ F capacitor in parallel with a 0.1 μ F bypass capacitor on this pin to remove high-frequency noise.



9.4 Layout

9.4.1 Layout Guidelines

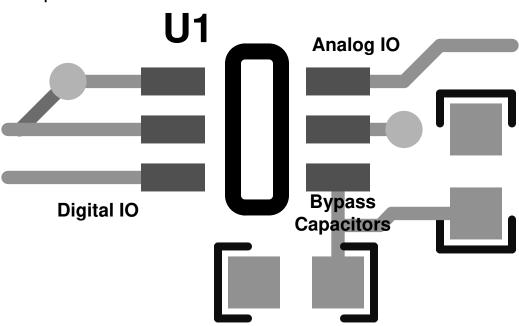
A precision analog component requires careful layout, adequate bypassing, and clean, well-regulated power supplies.

The DACx311 offers single-supply operation, and is often used in close proximity to digital logic, microcontrollers, microprocessors, and digital signal processors. The more digital logic present in the design and the higher the switching speed, the more difficult the task is to achieve good performance from the converter.

As a result of the single ground pin of the DACx311, all return currents, including digital and analog return currents, must flow through the GND pin. Ideally, GND is connected directly to an analog ground plane. Separate this plane from the ground connection for the digital components until connected at the power entry point of the system.

The power applied to AV_{DD} must be well-regulated and low-noise. Switching power supplies and dc/dc converters often have high-frequency glitches or spikes riding on the output voltage. In addition, digital components can create similar high-frequency spikes as the internal logic switches state. This noise can easily couple into the DAC output voltage through various paths between the power connections and analog output. This condition is particularly true for the DACx311, as the power supply is also the reference voltage for the DAC.

As with the GND connection, connect AV_{DD} to a 5-V power supply plane or trace that is separate from the connection for digital logic until connected at the power entry point. In addition, 1-µF to 10-µF and 0.1-µF bypass capacitors are strongly recommended. In some situations, additional bypassing can be required, such as a 100 µF electrolytic capacitor or even a *Pi* filter made up of inductors and capacitors—all designed to essentially low-pass filter the 5-V supply and remove high-frequency noise.



9.4.2 Layout Example

Figure 9-10. Recommended Layout



10 Device and Documentation Support

10.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Subscribe to updates* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

10.2 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

10.3 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

10.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.5 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
	()		-		-	()	(6)	(-)			
DAC5311IDCKR	ACTIVE	SC70	DCK	6	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	D53	Samples
DAC5311IDCKT	ACTIVE	SC70	DCK	6	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	D53	Samples
DAC6311IDCKR	ACTIVE	SC70	DCK	6	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	D63	Samples
DAC6311IDCKT	ACTIVE	SC70	DCK	6	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	D63	Samples
DAC6311IDCKTG4	ACTIVE	SC70	DCK	6	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	D63	Samples
DAC7311IDCKR	ACTIVE	SC70	DCK	6	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	D73	Samples
DAC7311IDCKT	ACTIVE	SC70	DCK	6	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	D73	Samples
DAC7311IDCKTG4	ACTIVE	SC70	DCK	6	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	D73	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF DAC5311 :

Automotive : DAC5311-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects



Texas

NSTRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DAC5311IDCKR	SC70	DCK	6	3000	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
DAC5311IDCKT	SC70	DCK	6	250	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
DAC6311IDCKR	SC70	DCK	6	3000	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
DAC6311IDCKT	SC70	DCK	6	250	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
DAC7311IDCKR	SC70	DCK	6	3000	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3
DAC7311IDCKT	SC70	DCK	6	250	178.0	9.0	2.4	2.5	1.2	4.0	8.0	Q3



www.ti.com

PACKAGE MATERIALS INFORMATION

9-May-2023



Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DAC5311IDCKR	SC70	DCK	6	3000	180.0	180.0	18.0
DAC5311IDCKT	SC70	DCK	6	250	180.0	180.0	18.0
DAC6311IDCKR	SC70	DCK	6	3000	180.0	180.0	18.0
DAC6311IDCKT	SC70	DCK	6	250	180.0	180.0	18.0
DAC7311IDCKR	SC70	DCK	6	3000	180.0	180.0	18.0
DAC7311IDCKT	SC70	DCK	6	250	180.0	180.0	18.0

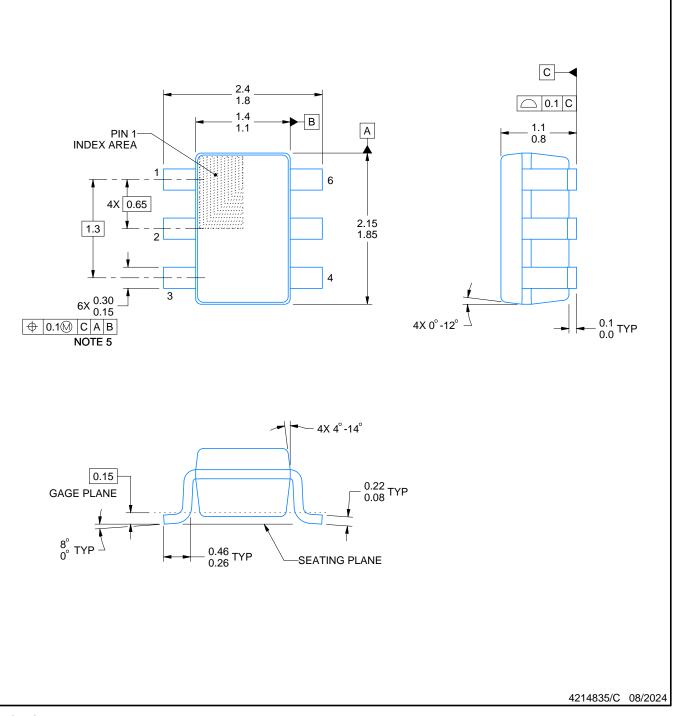
DCK0006A



PACKAGE OUTLINE

SOT - 1.1 max height

SMALL OUTLINE TRANSISTOR



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing an integration of a constraint of the minimeters. Any dimensions in parentnesis are for reference only. Dimensioning and to per ASME Y14.5M.
 This drawing is subject to change without notice.
 Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
 Falls within JEDEC MO-203 variation AB.

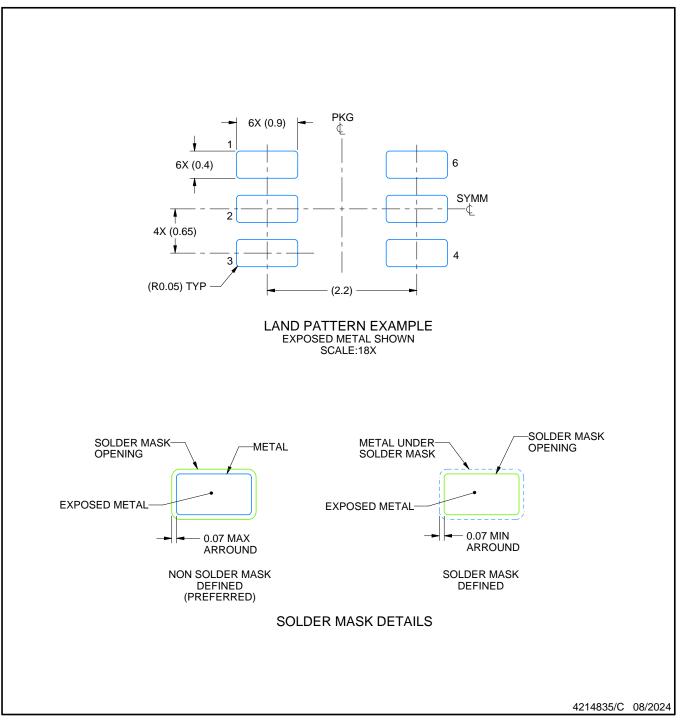


DCK0006A

EXAMPLE BOARD LAYOUT

SOT - 1.1 max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.

6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

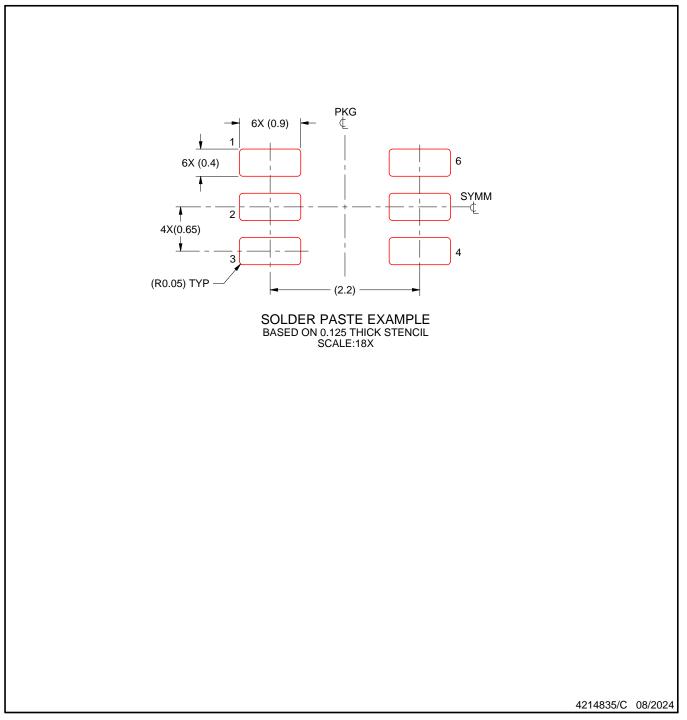


DCK0006A

EXAMPLE STENCIL DESIGN

SOT - 1.1 max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

8. Board assembly site may have different recommendations for stencil design.



^{7.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2024, Texas Instruments Incorporated